# Superconducting Sr<sub>0.85</sub>La<sub>0.15</sub>CuO<sub>2</sub> bicrystal grain boundary Josephson junctions

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### Outline

- 1. Motivation of the work the electron-doped infinitelayer type  $Sr_{1-x}La_xCuO_2$  high  $T_c$  superconductors
- 2.  $Sr_{1-x}La_xCuO_2$  (x=0.125-0.15) thin films: PLD growth by the reduction method and characterization (RHEED, XRD, HRTEM, RBS)
- 3. Grain boundary  $Sr_{1-x}La_xCuO_2$  (x=0.15) Josephson junctions
- 4. Conclusions

## The Sr<sub>1-x</sub>La<sub>x</sub>CuO<sub>2</sub> (SLCO) compounds



### Motivation of the work

- Studies on the Sr<sub>1-x</sub>La<sub>x</sub>CuO<sub>2</sub> (x=0.10-0.175) thin films role of the epitaxial strain on structural and transport properties for PLD grown films on different substrates: (001) SrTiO<sub>3</sub>, (001) KTaO<sub>3</sub>, and (110) DyScO<sub>3</sub>
- 2. Transport properties of Sr<sub>1-x</sub>La<sub>x</sub>CuO<sub>2</sub> grain-boundary Josephson junctions
- 3. Studies on the *order parameter symmetry* based on grain boundary Josephson junctions and phase sensitive experiments (on tetracrystals, using 0- and  $\pi$ -SQUIDs) for different La doping levels (x=0.10-0.175) and temperatures (2 K-T<sub>c</sub>)
- 4. *Physics at the interface* between p- and n-type HTSc superconductors (based on ramp-type Josephson junction technology)



SLCO plume





# $Sr_{1-x}La_{x}CuO_{2}$ (0.125-0.15) growth parameters

#### On (001) KTaO<sub>3</sub> and (110) $DyScO_3$

 $\frac{Sr_{1-x}La_xCuO_2}{T_d = 500-575 \circ C}$   $P_d = 0.20-0.40 \text{ mbar } O_2$ Post-deposition vacuum annealing (reduction) @ 10<sup>-7</sup> mbar:

- 15-20 min (KTaO<sub>3</sub> case)
- 20-30 min (DyScO<sub>3</sub> case)

#### T<sub>c</sub>: up to 24 K, on KTaO<sub>3</sub> up to 18 K, on DyScO<sub>3</sub>

Film's composition ( $x_t=0.15$  target), from RBS data:

-  $x_f = 0.145$ , films grown on KTaO<sub>3</sub>

-  $x_f = 0.135$ , films grown on DyScO<sub>3</sub>

**On BaTiO**<sub>3</sub>- **buffered (001)** SrTiO<sub>3</sub> <u>BaTiO</u><sub>3</sub>:  $T_d = 700-850 \circ C$   $P_d = 0.10 \text{ mbar O}_2$ Post-deposition annealing: -15 min @ 950°C, under 0.10 mbar O<sub>2</sub>, and 30 min @ 950°C, in vacuum (10<sup>-7</sup> mbar)

 $\frac{Sr_{1-x}La_xCuO_2}{T_d} = 550-600 \text{ °C}$   $P_d = 0.20 \text{ mbar } O_2$ Post-deposition annealing (reduction):
45-60 min @ 550 °C, in vacuum (10<sup>-7</sup> mbar)
Film's composition (x<sub>t</sub> = 0.15 target),
from RBS data: x<sub>f</sub> = 0.145
T<sub>c</sub>: up to 21 K

#### Highest reported T<sub>c</sub> values for PLD grown SLCO films!

Tomaschko, Leca, Selistrovski, Diebold, Jochum, Kleiner, Koelle, Phys. Rev. B 85 (2012)

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- c) after annealing  $(950^{\circ}C/1h/O_2) \implies$  SrO termination
- d) after chemical treatment (BHCl) and subsequent annealing  $(950^{\circ}C/1h/O_2) \Rightarrow TiO_2$  termination (high miscut angle case)

Control of the surface termination by selective removal of one of the surface oxides.

Kawasaki et al. Science 226 (1994) Koster et al. Appl. Phys. Lett 73 (1998) Leca, PhD thesis (2003)

# $Sr_{1-x}La_xCuO_2$ (x=0.15) grown on $BaTiO_3/SrTiO_3$ (001)



for sharp interface

annealing 15 min/950°C/0.10 mbar  $O_2$  and 30 min/950°C/10<sup>-7</sup> mbar

Tomaschko, Leca, Selistrovski, Diebold, Jochum, Kleiner, Koelle, Phys. Rev. B 85 (2012)



### Role of the epitaxial strain





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-15

C)

-10

-5

0

voltage (mV)

Tomaschko, Leca, Selistrovski,

conductance spectra did not show a zero-bias conductance peak. s-wave symmetry? however, the V-shaped of the spectra in the subgap regime may indicate an order parameter with nodes

Kleiner, Koelle, Phys. Rev. B 84 (2011)

5

10

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15

# Sr<sub>1-x</sub>La<sub>x</sub>CuO<sub>2</sub> 30° symmetric grain boundary junctions



dislocations in the (buffer) BaTiO<sub>3</sub> and SLCO layers.

Triple axis

Double axis

### Conclusions

- the superconducting properties of the PLD grown electrondoped  $Sr_{1-x}La_xCuO_2$  thin films are still far of those of the bulk or of the MBE grown films; however, higher phase stability could be achieved by PLD compared with other deposition techniques;

- epitaxial strain controls the structural and transport properties of the films; see the role of the substrate;

- first 24° and 30° [001] tilt grain boundary junctions were fabricated and their transport properties studied; no zero bias conductance peak was observed, probably due to strong disorder at the barrier (oxygen vacancies, etc).





# Pairing symmetry from phase sensitive experiments



For  $d_{x^2-y^2}$ -wave symmetry: the  $\pi$ -SQUID consists of one 0-Josephson junction and one  $\pi$  Josephson junction ( $\pi$ -phase shift inside the SQUID loop).

#### Predominantly $d_{x^2-y^2}$ pairing symmetry



Tomaschko, Scharinger, Leca, Nagel, Kemmler, Selistrovski, Koelle, Kleiner, Phys. Rev. B 86 (2012) Chesca et al., PRL 90 (2003) Schulz et al., APL 76 (2000)